

Form PTO-1449 (REV. 1/06)			US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 126213		APPLICATION NO. 10/559,775	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)			APPLICANTS Lambertus MEULENBRUGGE et al.					
			FILING DATE February 1, 2006					
U.S. PATENT DOCUMENTS								
Examiner Initials	Cite No.	Document Number	Date	Name				
FT	1.	6,106,785	08/22/2000	Vladimir HAVLENA et al.				
FT	2.	4,133,791	01/09/1979	Christof KEMENATER et al.				
FT	3.	4,806,836	02/21/1989	Don W. WEBB				
FT	4.	3,636,326	01/18/1972	Dexter E. SMITH et al.				
FT	5.	6,644,332 B1	11/11/2003	Richard J. WINKLER et al.				
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Examiner Initials	Cite No.	Document Number	Date	Country		With English Abstract	With English Translation	
FT	6.	WO 03/054040 A1	07/03/2003	WIPO				
FT	7.	WO 00/17245	03/30/2000	WIPO				
FT	8.	GB 1,120,147	07/17/1968	GREAT BRITAIN				
FT	9.	GB 1,549,841	08/08/1979	GREAT BRITAIN				
OTHER DOCUMENTS								
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)						
FT	10.	ChemiSens CPA - Application Note 1, "Optimal Production Rate of a PVC Latex Reactor", (1987)						
FT	11.	Sabahat ERDOGAN et al., "Self-Tuning Control of Batch Polymerization Reactor", <i>Journal of Chemical Engineering of Japan</i> , Vol. 31, No. 4, pp. 499-505, (1998)						
FT	12.	A.A. KISS et al., "Model Predictive Control of Temperature of a PVC Emulsion Process", <i>Hungarian Journal of Industrial Chemistry</i> , Vol. 27, pp 117-123 (1999)						
EXAMINER /Fred Teskin/						DATE CONSIDERED 06/14/2006		
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								

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Examiner Initials	Cite No.	Document Number	Date	Name		
FT	13.	2003/0105247 A1	06/05/2003	Antonio Luiz Duarte BRAGANCA et al.		
FT	14.	2001/0042378 A1	11/22/2001	Dennis M. PFISTER et al.		
FT	15.	2001/0004461 A1	06/21/2001	Robert M. MOORE JR., et al.		
FT	16.	6,440,374 B1	08/27/2002	Jan JELINEK et al.		
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FT	18.	2003/0199656 A1	10/23/2003	Hans WESTMIJZE et al.		
FT	19.	10/561,165	12/16/2005	Johannes Jacobus Theodorus DE JONG et al.		
FT	20.	10/552,437	10/06/2005	Hendrikus Gerardus BOEVENBRINK et al.		
FT	21.	10/553,971	10/19/2005	Hans WESTMIJZE et al.		
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